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December 2013

FQP2N60C / FQPF2N60C

N-Channel QFET® MOSFET

600 V, 2 A, 4.7 Ω

Description

This N-Channel enhancement mode power MOSFET is • 2 A, 600 V, $R_{DS(on)}$ = 4.7 Ω (Max.) @ V_{GS} = 10 V, produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state • Low Gate Charge (Typ. 8.5 nC) resistance, and to provide superior switching performance

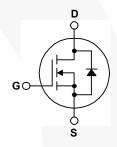
• Low Crss (Typ. 4.3 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power • 100% Avalanche Tested factor correction (PFC), and electronic lamp ballasts.

Features

- $I_D = 1 A$







Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQP2N60C	FQPF2N60C	Unit
V_{DSS}	Drain-Source Voltage		600		V
I _D	Drain Current - Continuous (T _C = 25°C)		2.0	2.0 *	Α
	- Continuous (T _C = 100°C)		1.35	1.35 *	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	8	8 *	Α
V _{GSS}	Gate-Source Voltage		± 30		V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	120		mJ
I _{AR}	Avalanche Current	(Note 1)	2.0		Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.4		mJ
dv/dt	Peak Diode Recovery dv/dt (Note		4.5		V/ns
P_{D}	Power Dissipation (T _C = 25°C)		54	23	W
	- Derate above 25°C		0.43	0.18	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300		°C

^{*} Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	FQP2N60C	FQPF2N60C	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.32	5.5	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ, Max.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQP2N60C	FQP2N60C	TO-220	Tube	N/A	N/A	50 units
FQPF2N60C	FQPF2N60C	TO-220F	Tube	N/A	N/A	50 units

Flactrical Characteristics

Parameter	Test Conditions	Min.	Тур.	Max.	Unit
aracteristics					
Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.6		V/°C
Zero Osto Valta va Brain Oversat	V _{DS} = 600 V, V _{GS} = 0 V			1	μΑ
Zero Gate Voltage Drain Current	V _{DS} = 480 V, T _C = 125°C			10	μА
Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V	-		-100	nA
aracteristics					
	V _{DS} = V _{GS} , I _D = 250 μA	2.0		4.0	V
Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1 A		3.6	4.7	Ω
Forward Transconductance	V _{DS} = 40 V, I _D = 1 A		5.0		S
ic Characteristics				1	
Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}.$		180	235	pF
Output Capacitance	f = 1.0 MHz		20	25	pF
Reverse Transfer Capacitance			4.3	5.6	pF
ing Characteristics					
ing Characteristics Turn-On Delay Time	V - 300 V I - 2 A		9	28	ns
	$V_{DD} = 300 \text{ V}, I_D = 2 \text{ A},$		9 25	28 60	ns ns
Turn-On Delay Time	$V_{DD} = 300 \text{ V}, I_{D} = 2 \text{ A},$ $R_{G} = 25 \Omega$				
Turn-On Delay Time Turn-On Rise Time			25	60	ns
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$ (Note 4)		25 24	60 58	ns ns
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	$R_G = 25 \Omega$ (Note 4) $V_{DS} = 480 \text{ V, } I_D = 2 \text{ A,}$		25 24 28	60 58 66	ns ns ns
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 \Omega$ (Note 4)		25 24 28 8.5	60 58 66	ns ns ns
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25 \Omega \tag{Note 4}$ $V_{DS} = 480 \text{V}, I_{D} = 2 \text{A},$ $V_{GS} = 10 \text{V} \tag{Note 4}$	 	25 24 28 8.5 1.3	60 58 66 12	ns ns ns nC
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25 \Omega \end{tabular} \begin{tabular}{l} (Note 4) \\ V_{DS} = 480 V, I_{D} = 2 A, \\ V_{GS} = 10 V \end{tabular} \begin{tabular}{l} (Note 4) \\ (Note 4) \\ \end{tabular}$	 	25 24 28 8.5 1.3 4.1	60 58 66 12 	ns ns ns nC nC
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Dio	$R_G = 25 \Omega$ (Note 4) $V_{DS} = 480 \text{ V}, I_D = 2 \text{ A}, V_{GS} = 10 \text{ V}$ (Note 4) and Maximum Ratings are Forward Current		25 24 28 8.5 1.3 4.1	60 58 66 12 	ns ns ns nC nC
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Diode Fall Time	$R_G = 25 \Omega$ (Note 4) $V_{DS} = 480 \text{ V}, I_D = 2 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4) and Maximum Ratings of the Forward Current Forward Current		25 24 28 8.5 1.3 4.1	60 58 66 12 2 8	ns ns nc nC nC
Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Dio	$R_G = 25 \Omega$ (Note 4) $V_{DS} = 480 \text{ V}, I_D = 2 \text{ A}, V_{GS} = 10 \text{ V}$ (Note 4) and Maximum Ratings are Forward Current		25 24 28 8.5 1.3 4.1	60 58 66 12 	ns ns ns nC nC
	Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse aracteristics Gate Threshold Voltage Static Drain-Source On-Resistance Forward Transconductance ic Characteristics Input Capacitance Output Capacitance	Drain-Source Breakdown Voltage $V_{GS} = 0 \text{ V}$, $I_D = 250 \text{ μA}$ Breakdown Voltage Temperature Coefficient $I_D = 250 \text{ μA}$, Referenced to 25° CZero Gate Voltage Drain Current $V_{DS} = 600 \text{ V}$, $V_{GS} = 0 \text{ V}$ Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse $V_{GS} = 30 \text{ V}$, $V_{DS} = 0 \text{ V}$ Gate-Body Leakage Current, Reverse $V_{GS} = -30 \text{ V}$, $V_{DS} = 0 \text{ V}$ Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = 250 \text{ μA}$ Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}$, $I_D = 1 \text{ A}$ Forward Transconductance $V_{DS} = 40 \text{ V}$, $I_D = 1 \text{ A}$ ic CharacteristicsInput Capacitance $V_{DS} = 25 \text{ V}$, $V_{GS} = 0 \text$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Drain-Source Breakdown Voltage $V_{GS} = 0 \text{ V}$, $I_D = 250 \text{ μA}$ 600Breakdown Voltage Temperature Coefficient $I_D = 250 \text{ μA}$, Referenced to 25°C 0.6Zero Gate Voltage Drain Current $V_{DS} = 600 \text{ V}$, $V_{GS} = 0 \text{ V}$ Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse $V_{GS} = 30 \text{ V}$, $V_{DS} = 0 \text{ V}$ Gate-Body Leakage Current, Reverse $V_{GS} = -30 \text{ V}$, $V_{DS} = 0 \text{ V}$ Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = 250 \text{ μA}$ 2.0Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}$, $I_D = 1 \text{ A}$ 3.6Forward Transconductance $V_{DS} = 40 \text{ V}$, $I_D = 1 \text{ A}$ 5.0ic CharacteristicsInput Capacitance $V_{DS} = 25 \text{ V}$, $V_{GS} = 0 \text{ V}$, $V_{GS} =$	

- Notes: 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. L = 56 mH, I_{AS} = 2 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C. 3. I_{SD} \leq 2 A, di/dt \leq 200 A/ μ s, V_{DD} \leq BV_{DSS}, starting T_{J} = 25°C. 4. Essentially independent of operating temperature.

Typical Characteristics

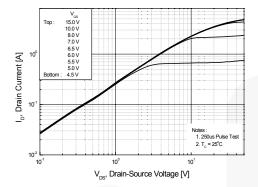


Figure 1. On-Region Characteristics

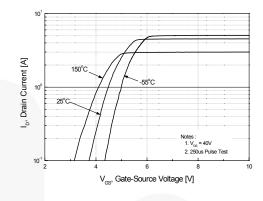


Figure 2. Transfer Characteristics

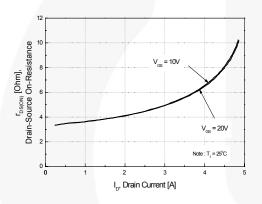


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

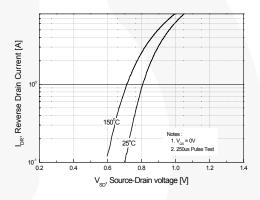


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

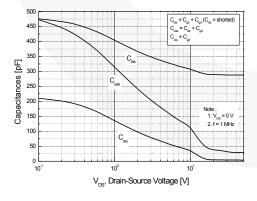


Figure 5. Capacitance Characteristics

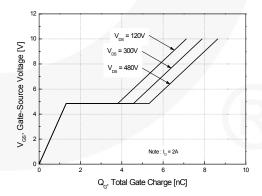


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

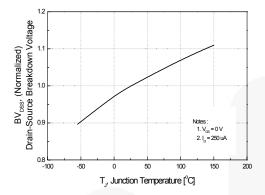


Figure 7. Breakdown Voltage Variation vs Temperature

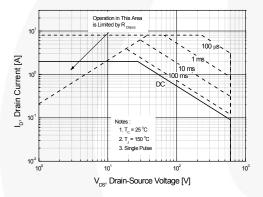


Figure 9-1. Maximum Safe Operating Area for FQP2N60C

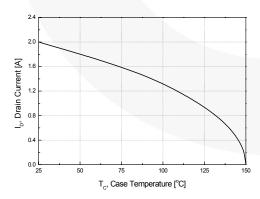


Figure 10. Maximum Drain Current vs Case Temperature

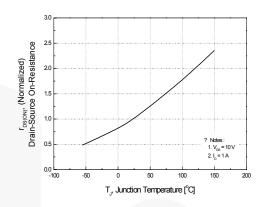


Figure 8. On-Resistance Variation vs Temperature

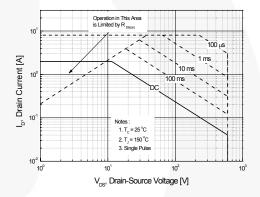


Figure 9-2. Maximum Safe Operating Area for FQPF2N60C

Typical Characteristics (Continued)

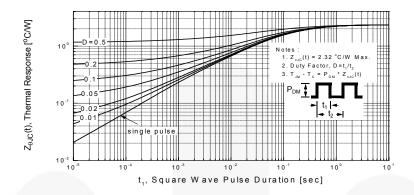


Figure 11-1. Transient Thermal Response Curve for FQP2N60C

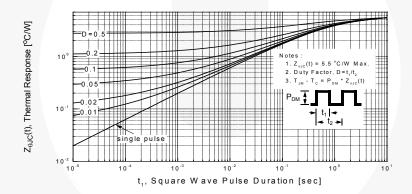


Figure 11-2. Transient Thermal Response Curve for FQPF2N60C

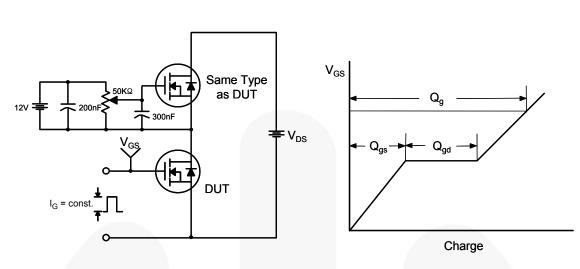


Figure 12. Gate Charge Test Circuit & Waveform

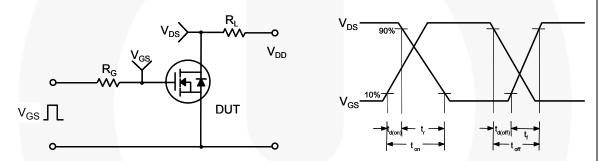


Figure 13. Resistive Switching Test Circuit & Waveforms

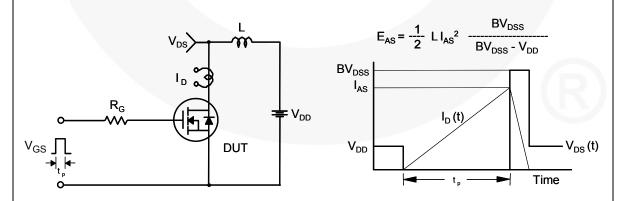
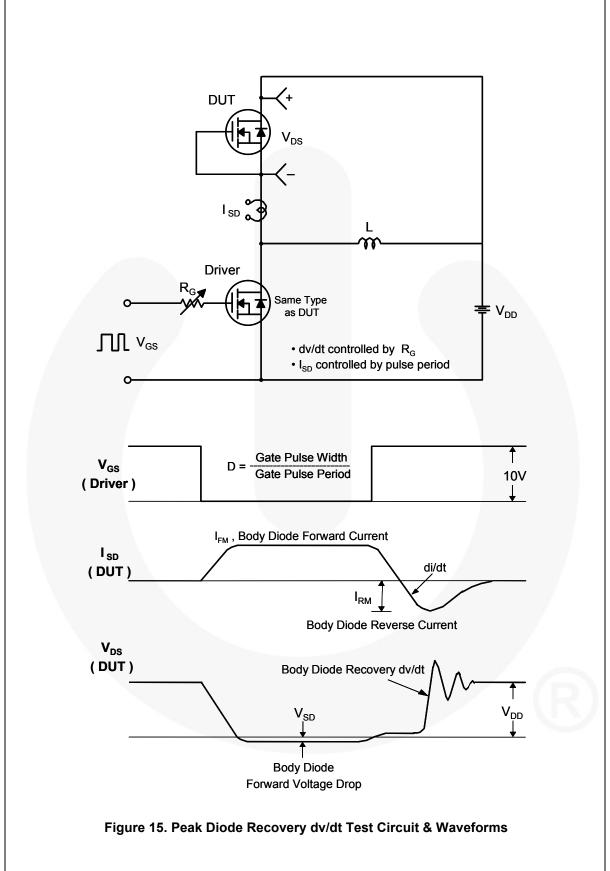


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

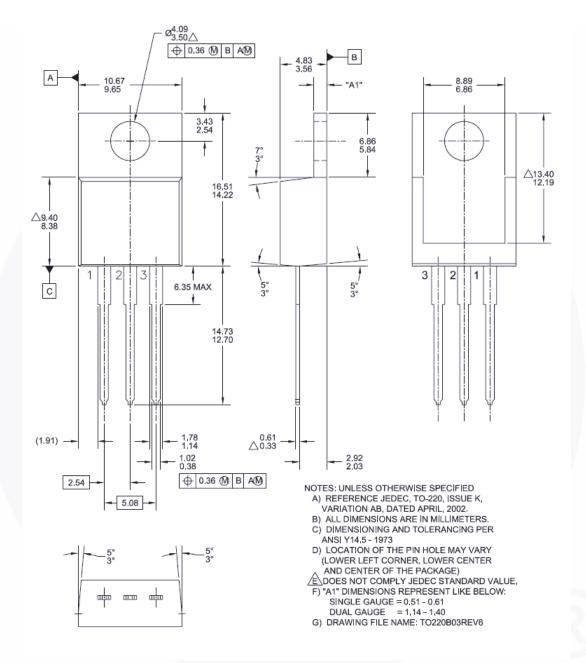


Figure 16. TO-220, Molded, 3-Lead, Jedec Variation AB

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Mechanical Dimensions

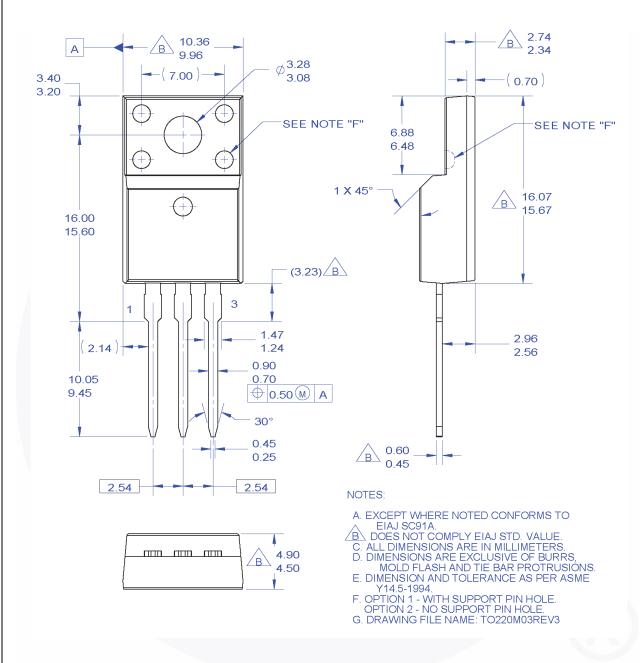


Figure 17. TO220, Molded, 3-Lead, Full Pack, EIAJ SC91, Straight Lead

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